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YS

**NONFERROUS METALS INDUSTRY STANDARD OF THE
PEOPLE'S REPUBLIC OF CHINA**

YS/T 981.1-2024

Replacing YS/T 981.1-2014

**Chemical analysis method of high purity indium - Part 1:
Determination of trace impurity element content - Glow
discharge mass spectrometry**

高纯铟化学分析方法 第1部分：痕量杂质元素含量的测定 辉光放电质谱法
(English Translation)

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What this standard covers

This standard specifies the method for determining the content of trace impurity elements in high-purity indium by glow discharge mass spectrometry. This standard applies to the determination of the content of trace impurity elements in high-purity indium.

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